

Phase diagrams of the AgIn_5Se_8 - AgGaSe_2 and AgIn_5Se_8 - Ga_2Se_3 systems of the quasi-ternary system Ag_2Se - Ga_2Se_3 - In_2Se_3

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Using X-ray diffraction, differential-thermal and microstructural analyses and microhardness measurements, the quasi-binary systems AgIn_5Se_8 - AgGaSe_2 and AgIn_5Se_8 - Ga_2Se_3 were investigated. Based on the results of the research, their phase diagrams were constructed.

X-ray phase analysis / Differential-thermal analysis / Microstructural analysis / Microhardness / Phase diagram

Introduction

Investigation of the AgIn_5Se_8 - AgGaSe_2 and AgIn_5Se_8 - Ga_2Se_3 systems is a necessary step in the study of the quasiternary system Ag_2Se - Ga_2Se_3 - In_2Se_3 . These systems may form large areas of solid solutions based on binary and ternary compounds, which can be used in semiconductor devices.

The Ag_2Se - In_2Se_3 system features one compound, AgIn_5Se_8 , which melts congruently at 1088 K. Its high-temperature modification crystallizes with tetragonal symmetry, space group (S.G.) $P-42m$, lattice parameters $a = 0.57934(4)$ nm, $c = 1.16223(2)$ nm [1]. The microhardness of AgIn_5Se_8 is 3.5 ± 0.01 GPa [2]. The Ag_2Se - Ga_2Se_3 system also features one compound, AgGaSe_2 , which melts congruently at 1123 K and crystallizes with tetragonal symmetry, S.G. $I-42m$, lattice parameters $a = 0.5992(5)$ nm, $c = 1.0886(1)$ nm [3]. The microhardness of AgIn_5Se_8 is 4.4 ± 0.01 GPa [4]. The Ga-Se system features a compound, Ga_2Se_3 , that melts congruently at 1293 K and crystallizes with cubic symmetry, S.G. $F-43m$, unit cell parameter $a = 0.5429(4)$ nm [5]. The microhardness of Ga_2Se_3 is 3.5 ± 0.01 GPa [6]. According to the literature data, all these compounds melt congruently, crystallize in the tetragonal or cubic system, and form solid solution ranges.

Experimental

Using the direct single-temperature method, 21 alloys of the AgIn_5Se_8 - AgGaSe_2 and AgIn_5Se_8 - Ga_2Se_3 systems were synthesized in evacuated quartz ampoules at 1150 K or 1290 K (depending on the

composition) from high-purity elements: Ag – 99.99 wt.%, Ga, In – 99.999 wt.% and Se – 99.9999 wt.%. The alloys were investigated by X-ray diffraction analysis (XRD), which was performed using a DRON 4-13 diffractometer with $\text{Cu K}\alpha$ -radiation (scan step 0.05° , exposure time 2 s), microstructure analysis (MSA) and microhardness measurements, using a Leica VMHT Auto microhardness tester. Differential thermal analysis (DTA) was performed using a device composed of a THERMODENT regulated heating furnace, an H-207 XY-recorder and a Pt-Pt/Rh thermocouple.

Results

Based on the XRD (Fig. 1) and DTA results, the phase diagram of the AgIn_5Se_8 - AgGaSe_2 system was constructed. It belongs to the Roozeboom type V (Fig. 2). It contains an α -solid solution range of the high-temperature modification (HTM) of AgIn_5Se_8 and a β -solid solution range of AgGaSe_2 . The lattice parameters (Fig. 3) in the AgIn_5Se_8 homogeneity region change from $a = 0.57994(2)$ nm, $c = 1.1622(1)$ nm for the compound AgIn_5Se_8 to $a = 0.57767(2)$ nm, $c = 1.1563(1)$ nm for the sample of composition 30 mol.% AgGaSe_2 – 70 mol.% AgIn_5Se_8 . The lattice parameter a in the AgGaSe_2 homogeneity region decreases from $0.59807(4)$ nm to $0.57789(3)$ nm, and the lattice parameter c increases from $1.0804(3)$ nm to $1.1427(1)$ nm, while the tetrahedral distortion of the unit cell, $\delta = 2-c/a$, decreases from 0.194 to 0.023. This is due to the replacement of Ga^{3+} ($r(\text{Ga}^{3+}) = 0.062$ nm [6]) by larger In^{3+} ($r(\text{In}^{3+}) = 0.076$ nm [6]), which leads to cell lengthening along the direction c . The XRD results

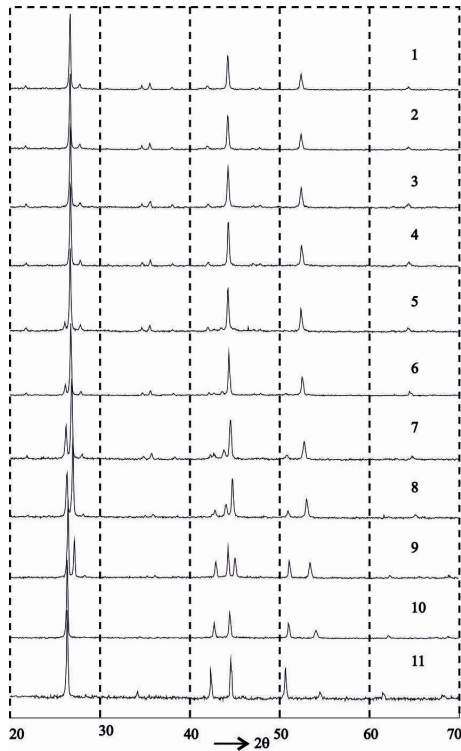


Fig. 1 X-ray powder diffraction diagrams of the samples of the AgIn_5Se_8 – AgGaSe_2 system annealed at 820 K:

- (1) 100 mol.% AgIn_5Se_8 ;
- (2) 90 mol.% AgIn_5Se_8 –10 mol.% AgGaSe_2 ;
- (3) 80 mol.% AgIn_5Se_8 –20 mol.% AgGaSe_2 ;
- (4) 70 mol.% AgIn_5Se_8 –30 mol.% AgGaSe_2 ;
- (5) 60 mol.% AgIn_5Se_8 –40 mol.% AgGaSe_2 ;
- (6) 50 mol.% AgIn_5Se_8 –50 mol.% AgGaSe_2 ;
- (7) 40 mol.% AgIn_5Se_8 –60 mol.% AgGaSe_2 ;
- (8) 30 mol.% AgIn_5Se_8 –70 mol.% AgGaSe_2 ;
- (9) 20 mol.% AgIn_5Se_8 –80 mol.% AgGaSe_2 ;
- (10) 10 mol.% AgIn_5Se_8 –90 mol.% AgGaSe_2 ;
- (11) 100 mol.% AgGaSe_2 .

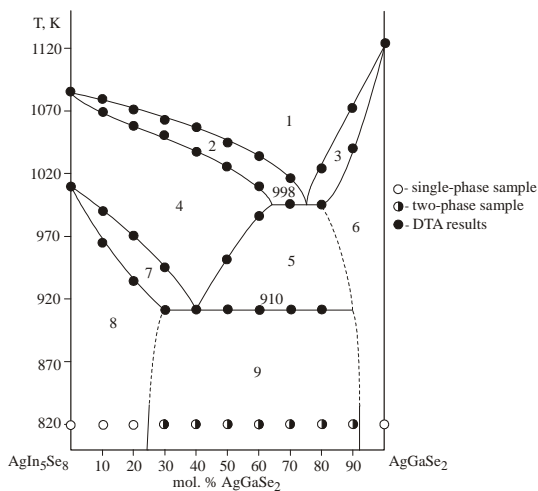


Fig. 2 Phase diagram of the AgIn_5Se_8 – AgGaSe_2 system: (1) L; (2) L+ α ; (3) L+ β ; (4) α ; (5) α + β ; (6) β ; (7) α + α' ; (8) α' ; (9) α' + β .

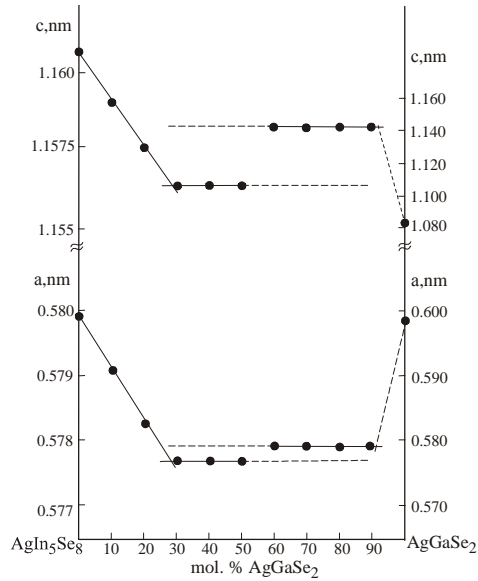


Fig. 3 Lattice parameters of the samples of the AgIn_5Se_8 – AgGaSe_2 system.

were confirmed by MSA and microhardness measurements (Table 1).

There is a eutectic point $L \leftrightarrow \alpha + \beta$ in the system with the coordinates 75 mol.% AgGaSe_2 – 25 mol.% HT- AgIn_5Se_8 , 998 K. The extent of the α -solid solution range at the eutectic temperature is 64 mol.% AgGaSe_2 , that of the β -solid solution range is 20 mol.% AgIn_5Se_8 . There is eutectoid dissolution of the α -solid solution, $\alpha \leftrightarrow \alpha' + \beta$ at 910 K, where α' is the solid solution of the low-temperature modification (LTM) of AgIn_5Se_8 ; the eutectoid point corresponds to a composition of 60 mol.% AgIn_5Se_8 – 40 mol.% AgGaSe_2 . The extent of the α' -solid solution range decreases from 30 mol.% AgGaSe_2 at the eutectoid temperature to 25 mol.% AgGaSe_2 at 820 K. The extent of the β -solid solution range varies from 10 to 8 mol.% AgIn_5Se_8 with decreasing temperature.

Diffraction patterns of the alloys in the AgIn_5Se_8 – Ga_2Se_3 system are plotted in Fig. 4. An α' -solid solution range of HT- AgIn_5Se_8 and a γ -solid solution range of Ga_2Se_3 form in this system. The lattice parameters in the α' -solid solution range change from $a = 0.57994(2)$ nm, $c = 1.1622(1)$ nm for AgIn_5Se_8 to $a = 0.56922(3)$ nm, $c = 1.1421(2)$ nm for the sample of composition 50 mol.% AgIn_5Se_8 – 50 mol.% Ga_2Se_3 . The lattice parameters in the γ -solid solution range change from $a = 0.5423(4)$ nm for Ga_2Se_3 to $a = 0.55793(2)$ nm for the sample of composition 80 mol.% Ga_2Se_3 – 20 mol.% AgIn_5Se_8 (Fig. 5). The XRD results were confirmed by MSA and microhardness measurements (Table 2).

Based on the XRD and DTA results, the phase diagram of the AgIn_5Se_8 – Ga_2Se_3 system, which belongs to type IV of Roozeboom's classification, was constructed (Fig. 6). There is a peritectic process $L + \gamma \leftrightarrow \alpha$ at 1115 K. The coordinates of the peritectic

Table 1 Microhardness and phase composition of the alloys of the AgIn_5Se_8 – AgGaSe_2 system.

No.	Nominal composition of the sample	Phase composition	Microhardness, GPa \pm 0.01	
1	100 mol.% AgIn_5Se_8	α	3.20	–
2	90 mol.% AgIn_5Se_8 –10 mol.% AgGaSe_2	α	3.25	–
3	80 mol.% AgIn_5Se_8 –20 mol.% AgGaSe_2	α	3.35	–
4	70 mol.% AgIn_5Se_8 –30 mol.% AgGaSe_2	α + β	(α) 3.48	(β) 3.88
5	60 mol.% AgIn_5Se_8 –40 mol.% AgGaSe_2	α + β	(α) 3.49	(β) 3.89
6	50 mol.% AgIn_5Se_8 –50 mol.% AgGaSe_2	α + β	(α) 3.49	(β) 3.89
7	40 mol.% AgIn_5Se_8 –60 mol.% AgGaSe_2	α + β	(α) 3.50	(β) 3.90
8	30 mol.% AgIn_5Se_8 –70 mol.% AgGaSe_2	α + β	(α) 3.49	(β) 3.92
9	20 mol.% AgIn_5Se_8 –80 mol.% AgGaSe_2	α + β	(α) 3.49	(β) 3.95
10	10 mol.% AgIn_5Se_8 –90 mol.% AgGaSe_2	α + β	(α) 3.51	4.15
11	100 mol.% AgGaSe_2	β	–	4.40

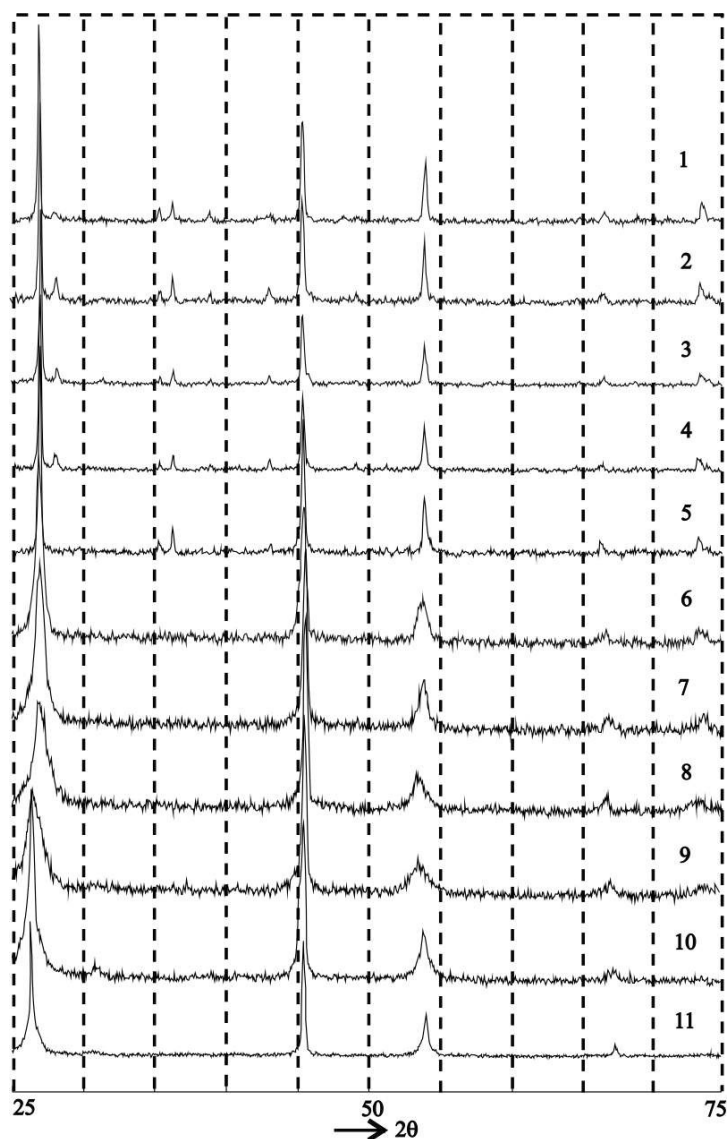


Fig. 4 X-ray powder diffraction diagrams of the samples in the AgIn_5Se_8 – Ga_2Se_3 system annealed at 820 K: (1) 100 mol.% AgIn_5Se_8 ; (2) 80 mol.% AgIn_5Se_8 –20 mol.% Ga_2Se_3 ; (3) 60 mol.% AgIn_5Se_8 –40 mol.% Ga_2Se_3 ; (4) 50 mol.% AgIn_5Se_8 –50 mol.% Ga_2Se_3 ; (5) 40 mol.% AgIn_5Se_8 –60 mol.% Ga_2Se_3 ; (6) 30 mol.% AgIn_5Se_8 –70 mol.% Ga_2Se_3 ; (7) 20 mol.% AgIn_5Se_8 –80 mol.% Ga_2Se_3 ; (8) 15 mol.% AgIn_5Se_8 –85 mol.% Ga_2Se_3 ; (9) 10 mol.% AgIn_5Se_8 –90 mol.% Ga_2Se_3 ; (10) 2 mol.% AgIn_5Se_8 –98 mol.% Ga_2Se_3 ; (11) 100 % Ga_2Se_3 .

Table 2 Microhardness and phase composition of the alloys of the $\text{AgIn}_5\text{Se}_8\text{-Ga}_2\text{Se}_3$ system.

No.	Nominal composition of the sample	Phase composition	Microhardness, $\text{GPa} \pm 0.01$	
1	100 mol.% AgIn_5Se_8	α	3.20	–
2	80 mol.% $\text{AgIn}_5\text{Se}_8\text{-}20$ mol.% Ga_2Se_3	α	2.40	–
3	60 mol.% $\text{AgIn}_5\text{Se}_8\text{-}40$ mol.% Ga_2Se_3	α	1.70	–
4	50 mol.% $\text{AgIn}_5\text{Se}_8\text{-}50$ mol.% Ga_2Se_3	$\alpha + \gamma$	(α) 1.44	(γ) 2.29
5	40 mol.% $\text{AgIn}_5\text{Se}_8\text{-}60$ mol.% Ga_2Se_3	$\alpha + \gamma$	(α) 1.46	(γ) 2.31
6	30 mol.% $\text{AgIn}_5\text{Se}_8\text{-}70$ mol.% Ga_2Se_3	$\alpha + \gamma$	(α) 1.45	(γ) 2.28
7	20 mol.% $\text{AgIn}_5\text{Se}_8\text{-}80$ mol.% Ga_2Se_3	$\alpha + \gamma$	(α) 1.48	(γ) 2.27
8	15 mol.% $\text{AgIn}_5\text{Se}_8\text{-}85$ mol.% Ga_2Se_3	γ	–	2.35
9	10 mol.% $\text{AgIn}_5\text{Se}_8\text{-}90$ mol.% Ga_2Se_3	γ	–	2.45
10	2 mol.% $\text{AgIn}_5\text{Se}_8\text{-}98$ mol.% Ga_2Se_3	γ	–	2.55
11	100 mol.% Ga_2Se_3	γ	–	3.00

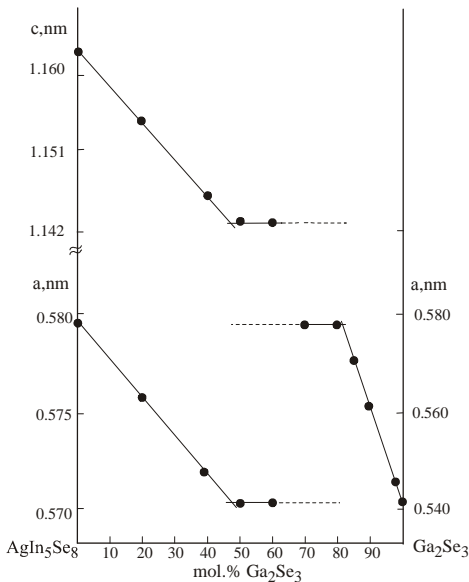


Fig. 5 Lattice parameters of the samples of the $\text{AgIn}_5\text{Se}_8\text{-Ga}_2\text{Se}_3$ system.

point are 75 mol.% Ga_2Se_3 , 1115 K. At this temperature the extent of the α -solid solution range is 80 mol.% AgGaSe_2 , that of the γ -solid solution range is 15 mol.% AgIn_5Se_8 . The peritectoid interaction of the α - and γ -solid solutions $\alpha + \gamma \leftrightarrow \alpha'$ takes place at 1030 K, with a coordinate of 50 mol.% Ga_2Se_3 for the peritectoid point. The extent of the α' -solid solution range is 45 mol.% Ga_2Se_3 at 820 K. At the same temperature the γ -solid solution extends to 18 mol.% AgIn_5Se_8 .

The phase diagrams of the $\text{AgIn}_5\text{Se}_8\text{-AgGaSe}_2$ and $\text{AgIn}_5\text{Se}_8\text{-Ga}_2\text{Se}_3$ systems were constructed. They belong to type V and type IV of Roozeboom's classification, respectively, and reveal the formation of large solid solutions ranges, which may serve as new semiconductor materials.

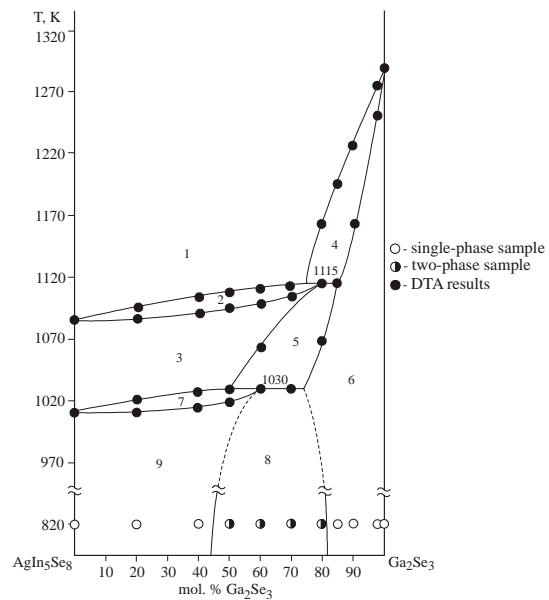


Fig. 6 Phase diagram of the $\text{AgIn}_5\text{Se}_8\text{-Ga}_2\text{Se}_3$ system: (1) L; (2) $L + \alpha$; (3) α ; (4) $L + \gamma$; (5) $\alpha + \gamma$; (6) γ ; (7) $\alpha + \alpha'$; (8) $\alpha' + \gamma$; (9) α' .

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